

# MOS FIELD EFFECT TRANSISTOR NP88N075CUE, NP88N075DUE, NP88N075EUE

# SWITCHING N-CHANNEL POWER MOS FET INDUSTRIAL USE

#### **DESCRIPTION**

These products are N-channel MOS Field Effect Transistor designed for high current switching applications.

#### **FEATURES**

- Channel temperature 175 degree rated
- Super low on-state resistance  $R_{DS(on)} = 8.5 \text{ m}\Omega$  MAX. (Vgs = 10 V, Ib = 44 A)
- Low Ciss : Ciss = 8200 pF TYP.

### **ORDERING INFORMATION**

PART NUMBER	PACKAGE
NP88N075CUE	TO-220AB
NP88N075DUE	TO-262
NP88N075EUE	TO-263

(TO-220AB)



(TO-262)



(TO-263)

# ABSOLUTE MAXIMUM RATINGS (TA = 25°C)

Drain to Source Voltage (Vss = 0 V)	Voss	75	V
Gate to Source Voltage (V <sub>DS</sub> = 0 V)	Vgss	±20	V
Drain Current (DC) Note1	I <sub>D(DC)</sub>	±88	Α
Drain Current (Pulse) Note2	D(pulse)	±352	Α
Total Power Dissipation (Tc = 25°C)	P <sub>T1</sub>	288	W
Total Power Dissipation (T <sub>A</sub> = 25°C)	$P_{T2}$	1.8	W
Channel Temperature	Tch	175	°C
Storage Temperature	T <sub>stg</sub>	-55 to +175	°C
Single Avalanche Current Note3	las	69 / 88	Α
Single Avalanche Energy Note3	Eas	450 / 14	mJ

**Notes 1.** Calculated constant current according to MAX. allowable channel temperature.

- **2.** PW  $\leq$  10  $\mu$ s, Duty cycle  $\leq$  1%
- **3.** Starting T<sub>ch</sub> = 25°C, R<sub>G</sub> = 25  $\Omega$  , V<sub>GS</sub> = 20  $\rightarrow$  0 V

# THERMAL RESISTANCE

Channel to Case Thermal Resistance	Rth(ch-C)	0.52	°C/W
Channel to Ambient Thermal Resistance	Rth(ch-A)	83.3	°C/W



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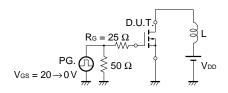
Not all devices/types available in every country. Please check with local NEC representative for availability and additional information.

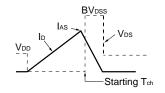


# **ELECTRICAL CHARACTERISTICS (TA = 25°C)**

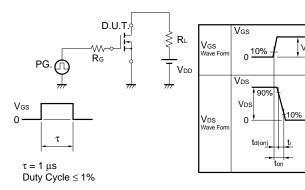
CHARACTERISTICS	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Zero Gate Voltage Drain Current	IDSS	V <sub>DS</sub> = 75 V, V <sub>GS</sub> = 0 V			10	μΑ
Gate Leakage Current	Igss	Vgs = ±20 V, Vps = 0 V			±100	nA
Gate to Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}$ , $I_D = 250 \mu\text{A}$	2.0	3.0	4.0	V
Forward Transfer Admittance	yfs	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 44 A	30	60		S
Drain to Source On-state Resistance	RDS(on)	Vgs = 10 V, ID = 44 A		6.2	8.5	mΩ
Input Capacitance	Ciss	Vps = 25 V		8200	12300	pF
Output Capacitance	Coss	Vgs = 0 V		800	1200	pF
Reverse Transfer Capacitance	Crss	f = 1 MHz		440	800	pF
Turn-on Delay Time	td(on)	VDD = 38 V, ID = 44 A		35	77	ns
Rise Time	tr	V <sub>GS(on)</sub> = 10 V		28	70	ns
Turn-off Delay Time	td(off)	$R_G = 0 \Omega$		105	210	ns
Fall Time	t <sub>f</sub>			16	40	ns
Total Gate Charge	Q <sub>G</sub>	V <sub>DD</sub> = 60 V		150	230	nC
Gate to Source Charge	Qgs	V <sub>GS</sub> = 10 V		30		nC
Gate to Drain Charge	Q <sub>GD</sub>	ID = 88 A		52		nC
Body Diode Forward Voltage	V <sub>F</sub> (S-D)	IF = 88 A, VGS = 0 V		1.0		V
Reverse Recovery Time	trr	IF = 88 A, VGS = 0 V		80		ns
Reverse Recovery Charge	Qrr	di/dt = 100 A/μs		240		nC

#### **TEST CIRCUIT 1 AVALANCHE CAPABILITY**





#### **TEST CIRCUIT 2 SWITCHING TIME**



90%

90%

toff

#### **TEST CIRCUIT 3 GATE CHARGE**

# TYPICAL CHARACTERISTICS (TA = 25°C)

Figure 1. DERATING FACTOR OF FORWARD BIAS SAFE OPERATING AREA

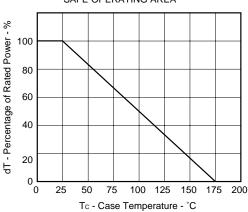


Figure 2. TOTAL POWER DISSIPATION vs. CASE TEMPERATURE

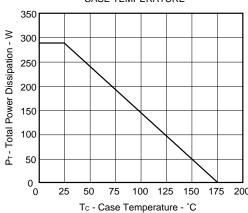


Figure 3. FORWARD BIAS SAFE OPERATING AREA

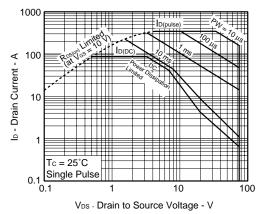
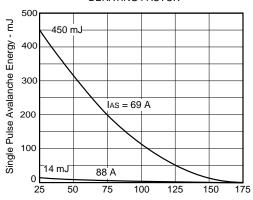


Figure 4. SINGLE AVALANCHE ENERGY DERATING FACTOR



Starting Tch - Starting Channel Temperature - °C

Figure 5. TRANSIENT THERMAL RESISTANCE vs. PULSE WIDTH

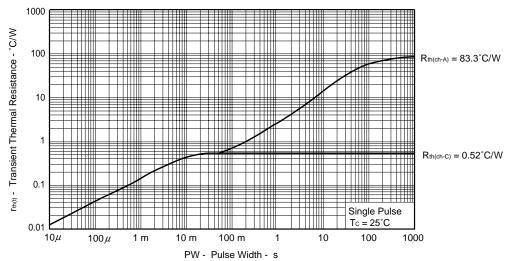


Figure 6. FORWARD TRANSFER CHARACTERISTICS

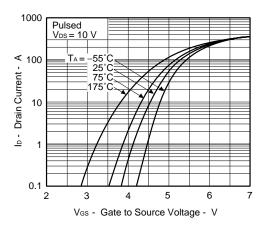


Figure8. FORWARD TRANSFER ADMITTANCE vs. DRAIN CURRENT

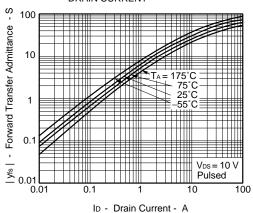


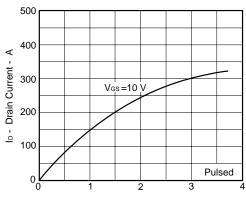
Figure 10. DRAIN TO SOURCE ON-STATE RESISTANCE vs. DRAIN CURRENT  $\mathsf{R}_{\mathsf{DS}(\mathsf{on})}$  - Drain to Source On-state Resistance -  $m\Omega$ Pulsed  $V_{GS} = 10$ 10 5

10

ID - Drain Current - A

100

Figure7. DRAIN CURRENT vs.
DRAIN TO SOURCE VOLTAGE



V<sub>DS</sub> - Drain to Source Voltage - V

Figure9. DRAIN TO SOURCE ON-STATE RESISTANCE vs. GATE TO SOURCE VOLTAGE СШ

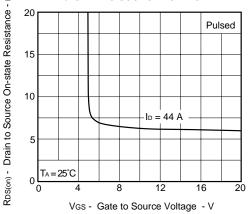
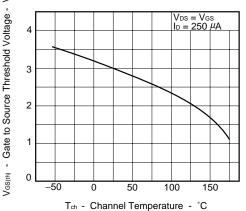


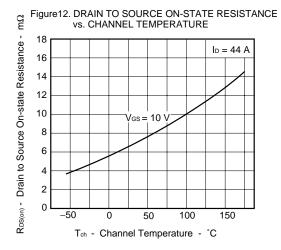
Figure 11. GATE TO SOURCE THRESHOLD VOLTAGE vs. CHANNEL TEMPERATURE >

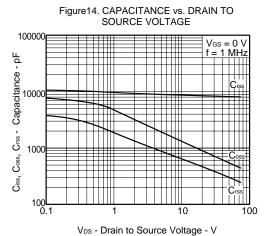


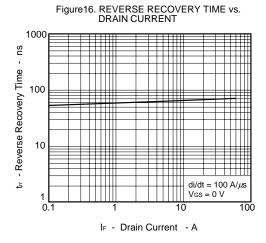
Data Sheet D14676EJ4V0DS

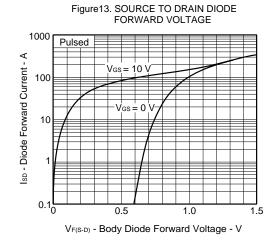
1000

0









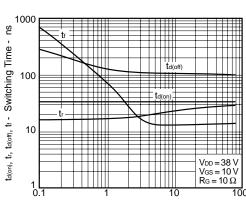
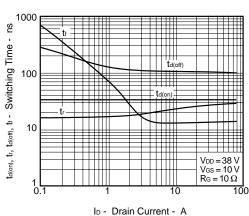


Figure 15. SWITCHING CHARACTERISTICS



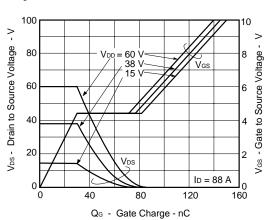
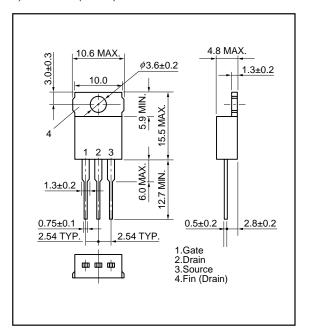


Figure 17. DYNAMIC INPUT/OUTPUT CHARACTERISTICS

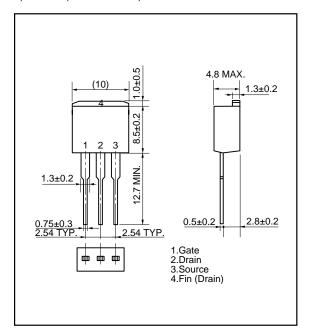


# PACKAGE DRAWINGS (Unit: mm)

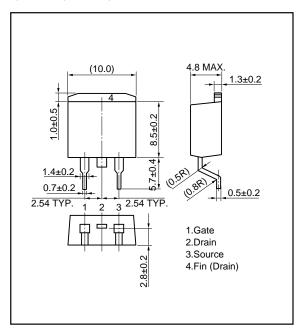
#### 1) TO-220AB (MP-25)



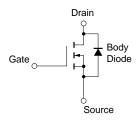
#### 2) TO-262 (MP-25 Fin Cut)



# 3) TO-263 (MP-25ZJ)



# **EQUIVALENT CIRCUIT**



**Remark** Strong electric field, when exposed to this device, can cause destruction of the gate oxide and ultimately degrade the device operation. Steps must be taken to stop generation of static electricity as much as possible, and quickly dissipate it once, when it has occurred.



[MEMO]

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